

AAEON

AAEON Technology INC.
ISO-9001/ISO-14001 Certified
Industrial Automation PCs

OPD-217 EVT

Temperature Test Report

Release Date : Jan/04/2002

Issue Stamp

QE Manager

Test Engineer

Environment

Model Name : OPD-217 EVT

Test Date : 01-04-2002

Test Site : AAEON QE Dept.

Performed by : Rex Chang

Test Standard :

Select	NO.	Description
√	IEC 68-2-61	Test Z/ABD : Climatic Sequence Test

Testing Item :

Temperature & Humidity Cycle

Additional Test Peripheral :

Configuration	Model
Test O.S.	Win98SE
Test Software	PassMark BurnIn Test Pro v2.2

Testing Equipment :

Programmable Temperature & Humidity Chamber

Model : Ths-D4L+-100

S/N : 1241

Date of Calibration : 07-10-2001

Sample Configuration & Quantity Under Test :

System Information:

OPD-217 17" TFT Display

System (TBOX-3300A)

1.Chipset: Intel 440BX

2.CPU: Intel Celeron 366 MHz

3.Memory: 64M SDRAM

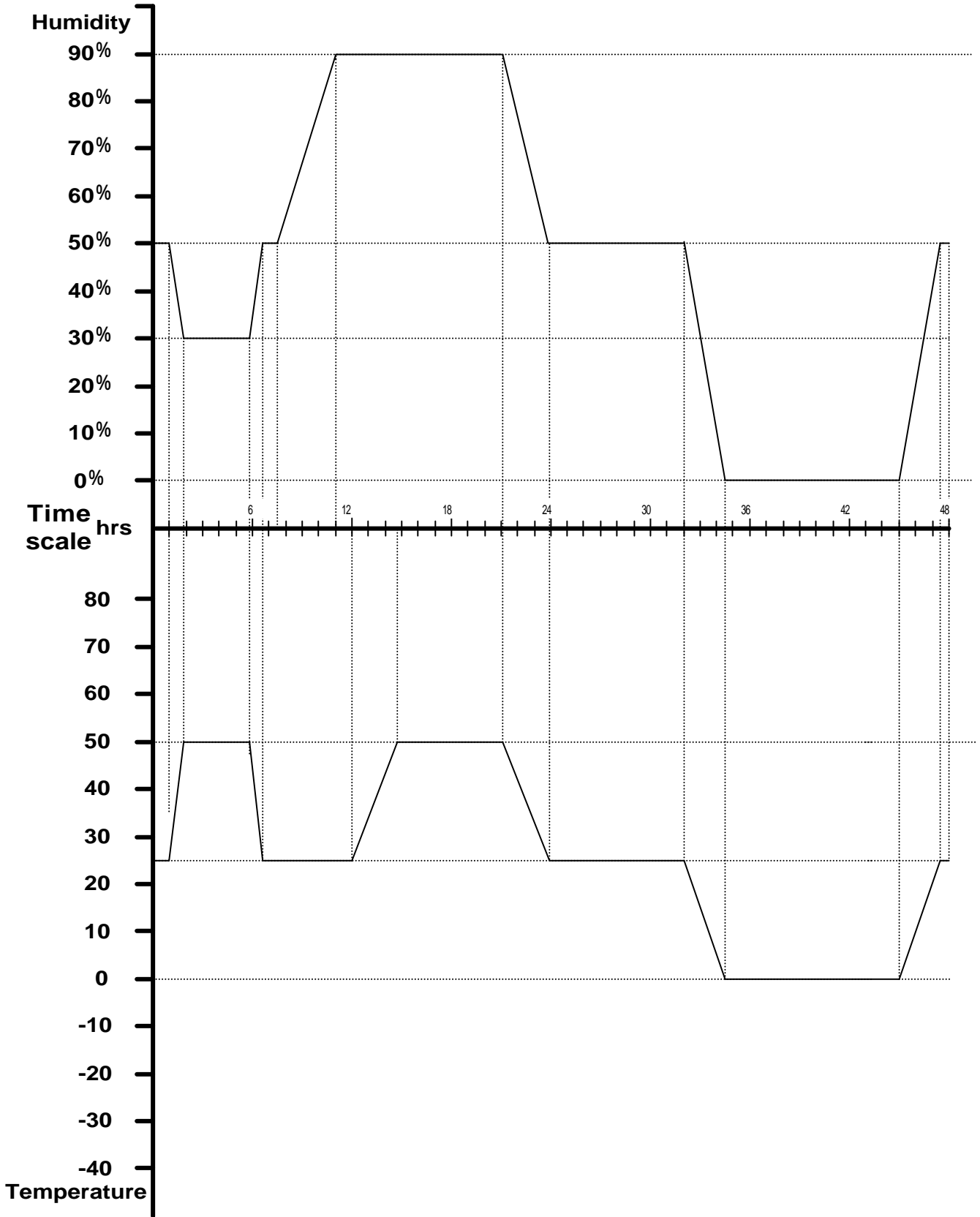
4.VGA: C&T 69000

Test Result :

Standard	Description	Result
IEC 68-2-61	Temperature & Humidity Cycle Test (Run PassMark BurnIn Test Pro v2.2)	Pass

Environment

Temperature & Humidity Cycle Test (Run PassMark BurnIn Test Pro v2.2)



Environment

Temperature & Humidity Cycle Test (Run PassMark BurnIn Test Pro v2.2)

